Search Notes

Application/Control No.	Applicant(s)/Patent und r Reexamination	
10/695,449	COHEN ET AL.	
Examiner	Art Unit	
Dang T. Nguyen	2824	

SEARCHED					
Class	Subclass	Date	Examiner		
365	185.19	6/28/2006	DN		
365	185.24	6/28/2006	DN		
365	185.33	6/28/2006	DN		
365	185.25	6/28/2006	DN		
365	185.28	6/28/2006	DN		
365	189.03	6/28/2006	DN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
365	185.19	6/28/2006	DN		
365	185.24	6/28/2006	DN		
365	185.33	6/28/2006	DN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
East (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB)	6/28/2006	DN			
Consulted to Primary Van Thu Nguyen and Son Dinh	6/28/2006	DN			
Interference search printout	6/28/2006	DN			
365/185.33 (text search only see search history report printout)	6/28/2006	DN			